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1 Recombination process of laser produced ZnO plasma in a gas atmosphere

Namba, S.; Nodu, R.; Takiyama, K.; Plasma Science, 2003. ICOPS 2003. IEEE Conference Record - Abstracts. The International Conference on , 2-5 June 2003

Pages:367

[Abstract] [PDF Full-Text (193 KB)] **IEEE CNF**

2 LPC compressed speech at 850 bits-per-second

Kun-Shan Lin; Ying Tsui;

Acoustics, Speech, and Signal Processing, IEEE International Conference on

ICASSP '81 , Volume: 6 , Apr 1981

Pages: 5 - 7

[Abstract] [PDF Full-Text (49 KB)] **IEEE CNF**

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